N-Channel 40V, 0.7mΩ Typ. Power MOSFET

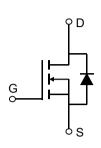
Description

Features

• 40V, 285A

 $R_{DS(ON)}$ Typ = 0.7m Ω @ V_{GS} = 10V

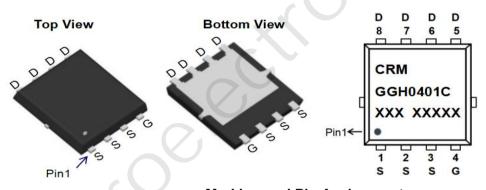
- Advanced Split Gate Trench Technology
- Excellent R_{DS(ON)} and Low Gate Charge
- 100% UIS TESTED!
- 100% ΔVds TESTED!





Application

- Load Switch
- PWM Application
- Power Management



Marking and Pin Assignment

Package Marking and Ordering Information

Device	Marking	Package	Outline	Reel Size	Reel (pcs)	Per Carton (pcs)
CRMGGH0401C	CRMGGH0401C	PDFN5x6-8L	TAPING	13"	5000	60000

Absolute Maximum Ratings (@ T_J = 25°C unless otherwise specified)

Symbol	Parameter		Value	Units
V_{DS}	Drain-to-Source Voltage		40	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Cumant	T _C = 25°C	285	А
I _D	Continuous Drain Current	T _C = 100°C	171	А
I_{DM}	Pulsed Drain Current ⁽¹⁾		1140	А
E _{AS}	Single Pulsed Avalanche Energy ⁽²⁾		841	mJ
P_{D}	Power Dissipation	T _C = 25°C	125	W
$R_{ heta JC}$	Thermal Resistance, Junction to Case		1	°C/W
T_J,T_STG	Junction & Storage Temperature Range		-55 to 150	°C

CRMGGH0401C

N-Channel 40V, 0.7mΩ Typ. Power MOSFET

Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Chara	acteristics			•		
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 40V, V _{GS} = 0V	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Chara	acteristics				6	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.3	2.8	3.4	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽³⁾	V _{GS} = 10V, I _D = 30A	-	0.7	0.9	mΩ
Dynamic	Characteristics					
C _{iss}	Input Capacitance		- /	5344	-	pF
C_{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	-	2363	-	pF
C_{rss}	Reverse Transfer Capacitance	1 - 1101112	X-\	200	-	pF
Q_g	Total Gate Charge		- 1	75	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_{D} = 30A$) .	19	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} - 20V, I _D - 30A	-	17.5	-	nC
Switchin	g Characteristics					
t _{d(on)}	Turn-On DelayTime		-	8.5	-	ns
t_r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	15	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 30A, R_{GEN} = 1.6\Omega$	-	52	-	ns
\mathbf{t}_{f}	Turn-Off Fall Time		-	12	-	ns
Orain-So	urce Diode Characteristics and M	Max Ratings				
I _S	Maximum Continuous Drain to Source Di	ode Forward Current	-	-	285	Α
I _{SM}	Maximum Pulsed Drain to Source Diode	Forward Current	-	-	1140	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	L = 204 di/dt = 1004/va	-	22	-	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 30A$, di/dt = 100A/us	-	40	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

^{2.} E_{AS} condition: Starting T_J =25°C, V_{DD} =20V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =58A

^{3.} Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

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Test Circuit

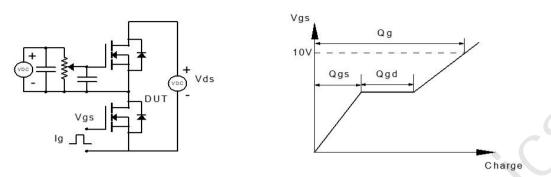


Figure 1: Gate Charge Test Circuit & Waveform

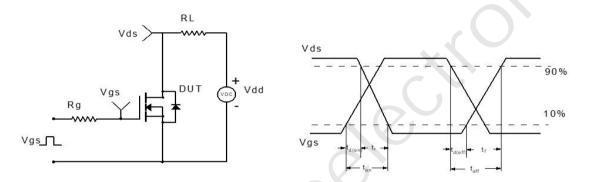


Figure 2: Resistive Switching Test Circuit & Waveform

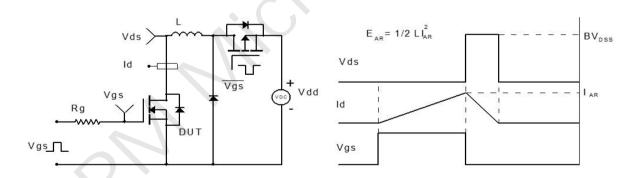


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

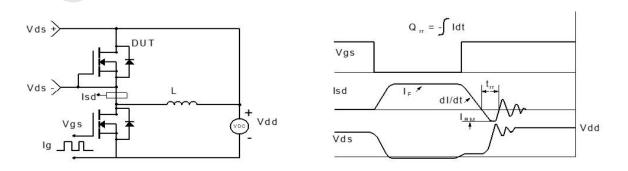
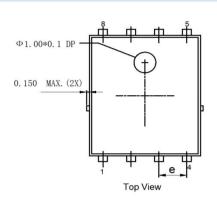


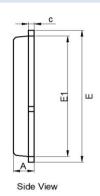
Figure 4: Diode Recovery Test Circuit & Waveform

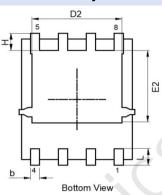
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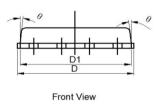
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Package Mechanical Data(PDFN5x6-8L)









DIM		MILLIMETER		
DIM.	MIN.	NOM.	MAX.	
Α	0.90	1.00	1.10	
b	0.31	0.41	0.51	
С	0.21	0.25	0.34	
D	5.05	5.20	5.40	
D1	4.95	5.05	5.15	
D2	4.00	4.10	4.20	
E	6.30	6.40	6.50	
E1	5.75	5.85	5.95	
E2	3.43	3.53	3.63	
е	1.27BSC			
Н	0.73	0.83	0.93	
L	0.61	0.71	0.81	
θ	0°		12°	

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